Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/511,605	YAMAGUCHI ET AL.	
Examiner	Art Unit	
Hwei-Siu C. Payer	3724	

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Class	Subclass	Date	Examiner
030	34.1	8-1-06	Vayer
	43.6		
	43.9		-
	43.92		
	526		
250	49		
	51		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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